Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination YAMAZAKI, TAKESHI	
10/667,914		
Examiner	Art Unit	
Shih-wen Hsieh	2861	

	SEAR	CHED	
Class	Subclass	Date	Examiner
updated	updated	9/22/2005	SWH
updated	updated	9/22/2005	sWH
		-	

			L

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
1			.,
	search (see ched)	9/22/2005	AMAL SWH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
4 - 1 - 1 - 1				
		:		